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Application/Control No.	Applicant(s)/Patent under Reexamination
10/085,530	HENDLEY ET AL.
Examiner	Art Unit
Jude J. Jean-Gilles	2143

SEARCHED				
Class	Subclass	Date	Examiner	
709	226-229 224	9/18/2005	JG	
707	1-3 103R 1	9/18/2005	JG	
345	740 966	9/18/2005	JG	
713	200-202	9/18/2005	JG	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		,		
	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
PAM tool: effective filing date double patenting	9/18/2005	1G	
EAST Tool: DERWENT EPO JPO USPAT	9/18/2005	JG	
Internet : google.com onelook.com NPLs IEEE	9/18/2005	JG	
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